

**Search Notes**

Application/Control No.

10/531,343

Examiner

/Yonel Beaulieu/

Applicant(s)/Patent under  
Reexamination

MICHIE ET AL.

Art Unit

3661

**SEARCHED**

Class	Subclass	Date	Examiner
701	200	10/15/2008	YB
	210		
	117		
	25-26		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Int. Search		10/15/2008	YB

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST+Int.+Bwd/Fwd	10/15/2008	YB